

## ON THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 10/050,347  
Filing Date ..... January 15, 2002  
Inventor ..... Gurtej S. Sandhu et al.  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2813  
Examiner ..... Laura M. Schillinger  
Attorney's Docket No. .... MI22-1897  
Title: Methods of Forming Transistors

### SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

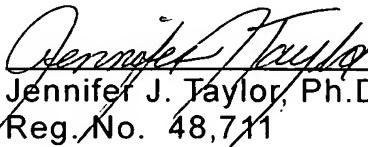
References -- See Attached Form PTO-1449

The attached Form PTO-1449 is submitted in compliance with 37 CFR §1.56. Pursuant to FEDERAL REGISTER, Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art are attached. No admission is made regarding whether the listed references are prior art.

Respectfully submitted,

Dated: February 22, 2007

By:

  
Jennifer J. Taylor, Ph.D.  
Reg. No. 48,711

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI22-1897		SERIAL NO. 10/050,347	
		<p>LIST OF ART CITED BY APPLICANT</p> <p>(Use several sheets if necessary)</p> <p style="text-align: center;">FEB 22 2007</p> <p style="text-align: center;">U.S. PATENT &amp; TRADEMARK OFFICE</p>			APPLICANT: Gurtej S. Sandhu			
					FILING DATE January 15, 2002		GROUP 2813	
<b>U.S. PATENT DOCUMENTS</b>								
*Examiner's Initials		Document Number	Date	Name		Class	Subclass	Filing Date If Appropriate
	AA	6,015,739	1/18/00	Gardner et al.				
	AB	6,057,854	05/2/00	Gardner et al.				
	AC	6,649,58 B1	11/18/03	Cheng et al.				
	AD	2005/0087820 A1	4/28/05	Bai et al.				
	AE	2006/0134864 A1	6/22/06	Higashitani et al.				
	AF							
	AG							
	AH							
	AI							
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country		Class	Subclass	Translation
								Yes      No
	AJ							
	AK							
	AL							
<b>OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AM							
	AN							
	AO							
	AP							
	AQ							
EXAMINER		DATE CONSIDERED						
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>								